



PRODUCT DATA SHEET



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Datasheet

ources Samples

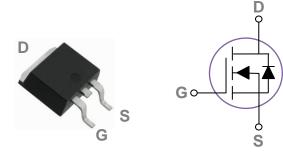
Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO_questions@jgsemi.com.



General Description

These N-Channel enhancement mode power field effect transistors are using trench Split Gate Trench technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

T0252	Din	Configuration



BVDSS	RDSON	ID
100V	13m Ω	60A

Features

- $100V,60A, RDS(ON) = 13m\Omega@VGS = 10V$
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

Applications

- Networking
- Load Switch
- LED applications

Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	100	V
V _G S	Gate-Source Voltage	±20	V
1_	Drain Current – Continuous (Tc=25°C)	60	А
ID	Drain Current – Continuous (Tc=100°C)	28.5	А
I _{DM}	Drain Current – Pulsed ¹	180	А
EAS	Single Pulse Avalanche Energy ²	80	mJ
D	Power Dissipation (Tc=25°C)	65	W
P _D	Power Dissipation – Derate above 25°C	0.624	W/°C
T _{STG}	Storage Temperature Range	-50 to 150	°C
TJ	Operating Junction Temperature Range	-50 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
RθJA	Thermal Resistance Junction to ambient		62	°C/W
ReJC	Thermal Resistance Junction to Case		1.61	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Off Characteristics

Symbol	ymbol Parameter Conditions		Min.	Тур.	Max.	Unit
BV _{DSS}	BV _{DSS} Drain-Source Breakdown Voltage V _{GS} =0V , I _D =250uA		100			V
△BV _{DSS} /△T _J	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.06		V/°C
I	Drain-Source Leakage Current	V _{DS} =100V , V _{GS} =0V , T _J =25°C			1	uA
IDSS		V _{DS} =80V , V _{GS} =0V , T _J =125°C			10	uA
I _{GSS}	Gate-Source Leakage Current	V _{GS=} ±20V , V _{DS} =0V			±100	nA

On Characteristics

R _{DS(ON)} Static Drain-Source	Static Drain-Source On-Resistance	V _{GS} =10V , I _D =25A		13	19	mΩ
	Static Dialii-Source Off-Nesistance	V _{GS} =4.5V , I _D =20A		18	25	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	V V I- 250uA		1.7	2.5	V
$\triangle V_{GS(th)}$	△V _{GS(th)} V _{GS(th)} Temperature Coefficient V _{GS=V_{DS}} , I _D =250uA			-5.1		mV/°C
gfs	Forward Transconductance	V _{DS} =10V , I _D =3A		50		S

Dynamic and switching Characteristics

Q_g	Total Gate Charge ^{3, 4}		 14.8	
Qgs	Gate-Source Charge ^{3, 4}	V_{DS} =50 V , V_{GS} =10 V , I_{D} =20 A	 3.3	 nC
Q_{gd}	Gate-Drain Charge ^{3, 4}		 2.5	
$T_{d(on)}$	Turn-On Delay Time ^{3, 4}		 10.2	
Tr	Rise Time ^{3, 4} V_{DD} =50V , V_{GS} =10V , R_G =3 Ω		 3.6	 no
$T_{d(off)}$	Turn-Off Delay Time ^{3, 4}	I _D =10A	 11	 ns
T _f	Fall Time ^{3, 4}		 2.4	
Ciss	Input Capacitance		 998	
Coss	Output Capacitance	V_{DS} =50V , V_{GS} =0V , F =1MHz	 190	 pF
Crss	Reverse Transfer Capacitance		 4	
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz	 1.5	 Ω

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	Va-Va-OV Force Current			60	Α
Isм	Pulsed Source Current	V _G =V _D =0V , Force Current			120	Α
V_{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =1A , T _J =25°C			1.2	V

Note:

- Repetitive Rating : Pulsed width limited by maximum junction temperature.
- 2. $V_{DD}=50V$, $V_{GS}=10V$, L=0.1 mH, $I_{AS}=48$ A., $R_{G}=25\Omega$, Starting $T_{J}=25^{\circ}$ C.
- 3. The data tested by pulsed , pulse width ≤ 300 us , duty cycle $\leq 2\%$.
- 4. Essentially independent of operating temperature.



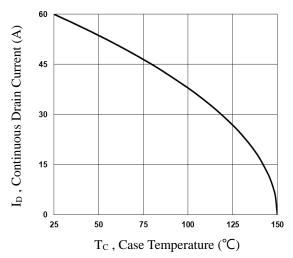


Fig.1 Continuous Drain Current vs. T_c

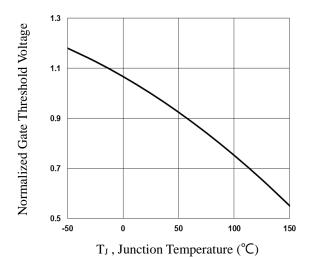


Fig.3 Normalized Vth vs. T_J

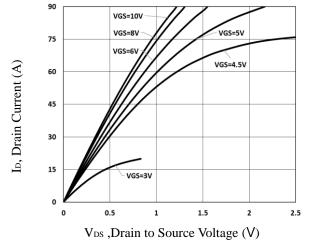


Fig.5 Typical Output Characteristics

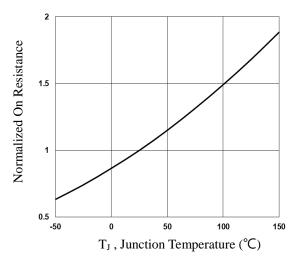


Fig.2 Normalized RDSON vs. T_J

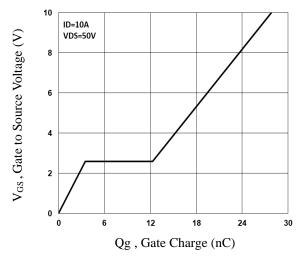


Fig.4 Gate Charge Characteristics

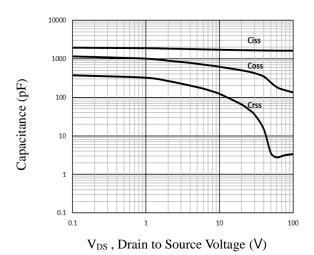


Fig.6 Capacitance Characteristics



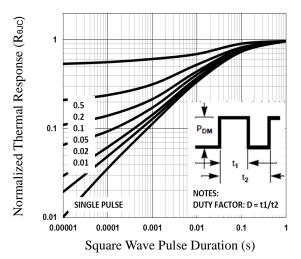


Fig.7 Normalized Transient Impedance

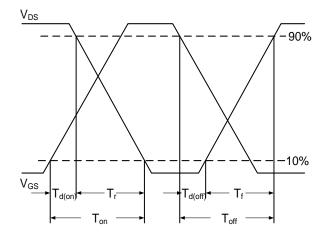


Fig.9 Switching Time Waveform

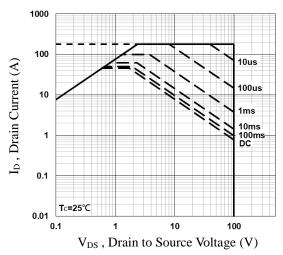


Fig.8 Maximum Safe Operation Area

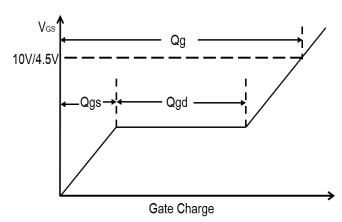
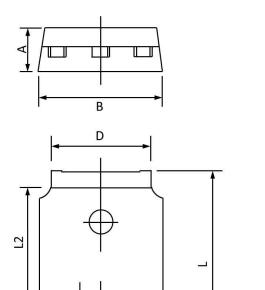
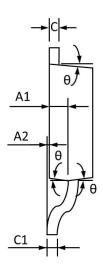


Fig.10 Gate Charge Waveform



TO252 PACKAGE INFORMATION





Crush ol	Dimensions 1	Dimensions In Millimeters		s In Inches
Symbol	Min	Max	Min	Max
A	2.20	2.40	0.087	0.094
A1	0.91	1.11	0.036	0.044
A2	0.00	0.15	0.000	0.006
В	6.50	6.70	0.256	0.264
C	0.46	0.580	0.018	0.230
C1	0.46	0.580	0.018	0.030
D	5.10	5.46	0.201	0.215
E	2.186	2.386	0.086	0.094
F	0.74	0.94	0.029	0.037
F 1	0.660	0.860	0.026	0.034
L	9.80	10.40	0.386	0.409
L1	2.9	2.9REF 0.114REF		REF
L2	6.00	6.20	0.236	0.244
L3	0.60	1.00	0.024	0.039
θ	3°	9°	3°	9°



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